Search Notes

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Application/Control No.	Applicant(s)/Patent under Reexamination	
09/461,521	HOHENSEE ET AL.	
Examiner	Art Unit	

Chau Nguyen

2176

SEARCHED				
Class	Subclass	Date	Examiner	
715	515	3/15/2005	CN	
715	516	3/15/2005	CN	
715	523	3/15/2005	CN	
715	539	3/15/2005	CN	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARCI)
	DATE	EXMR
East Reports	3/15/2005	CN
Inventors	3/15/2005	CN
NPL Search on IEEE Database	3/15/2005	CN